

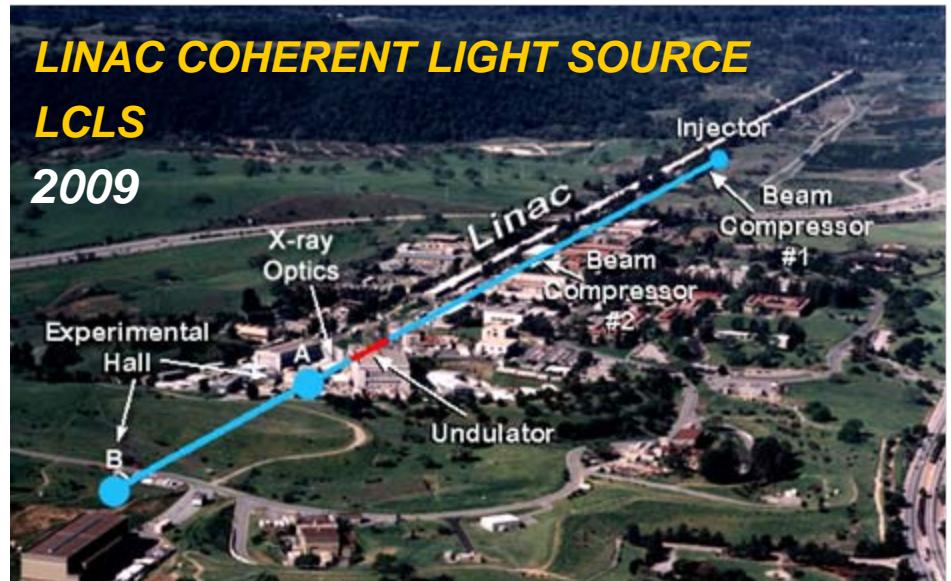
Detector Developments for the European XFEL.

Heinz Graafsma; DESY-Hamburg
4th Detector Workshop of the Helmholtz Alliance;
March 2011

- The FEL Detector Challenge
- The AGIPD project
- The DSSC project
- Summary / Conclusions



FEL Sources in the world

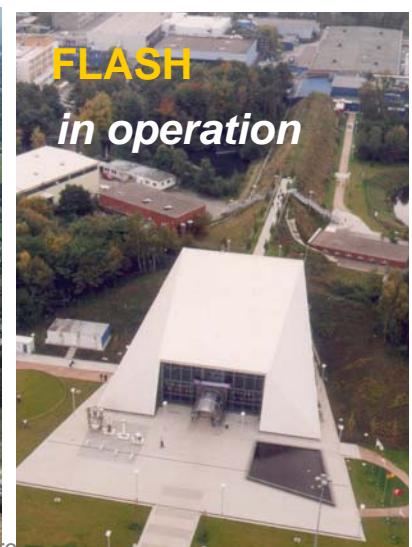


FLASH: 5 Hz, 10 Hz and 5 MHz

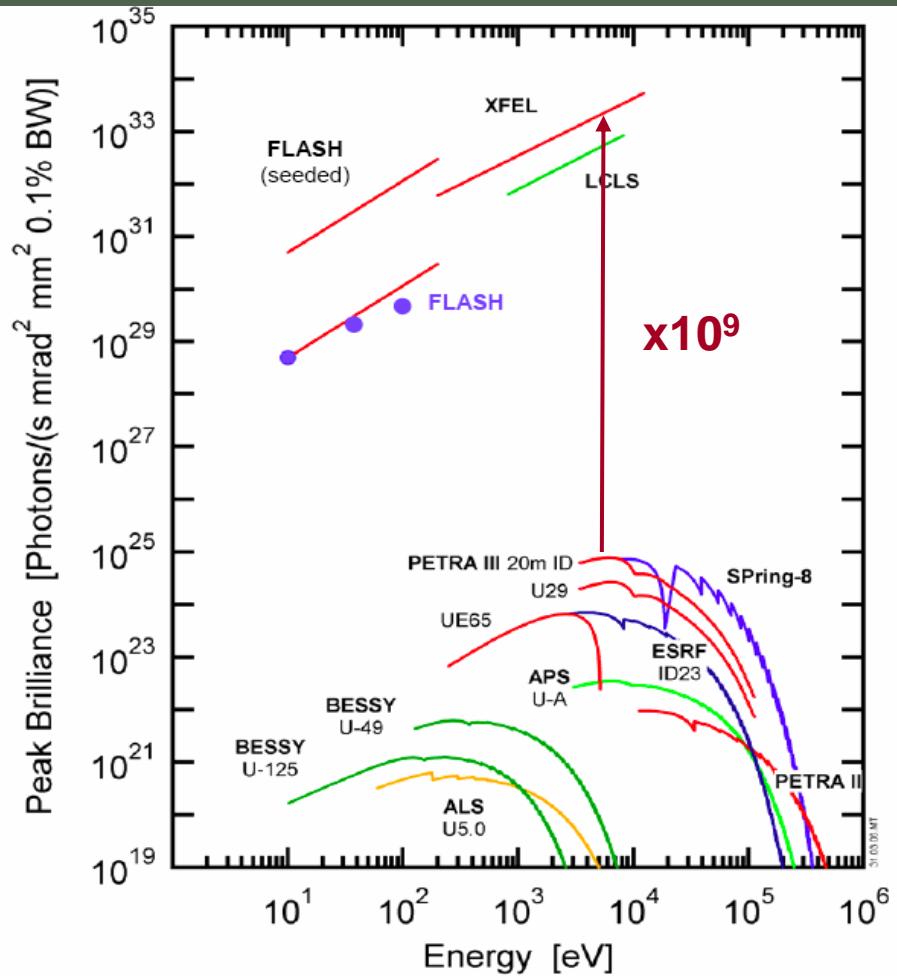
LCLS: 120 Hz

SCSS: 60 Hz

XFEL: 5 Hz, 10 Hz and 5 MHz



Challenge: Different Science



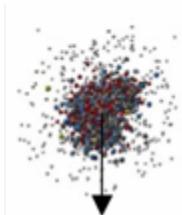
- Completely new science
- Fast science 100 fsec
- “Single shot” science

Single shot experiments

One pulse, one measurement

Particle injection

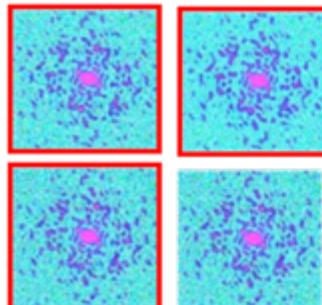
10 fs pulse



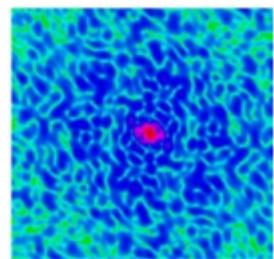
Noisy diffraction pattern

**Solve the well known
Phase Problem**

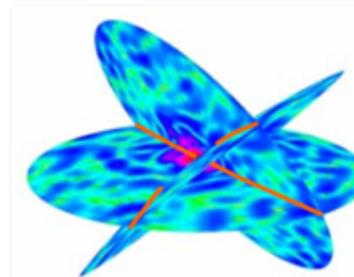
Combine 10^5 - 10^7 measurements



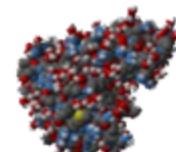
Classification



Averaging



Orientation



Reconstruction
DESY

Overall layout of the European XFEL



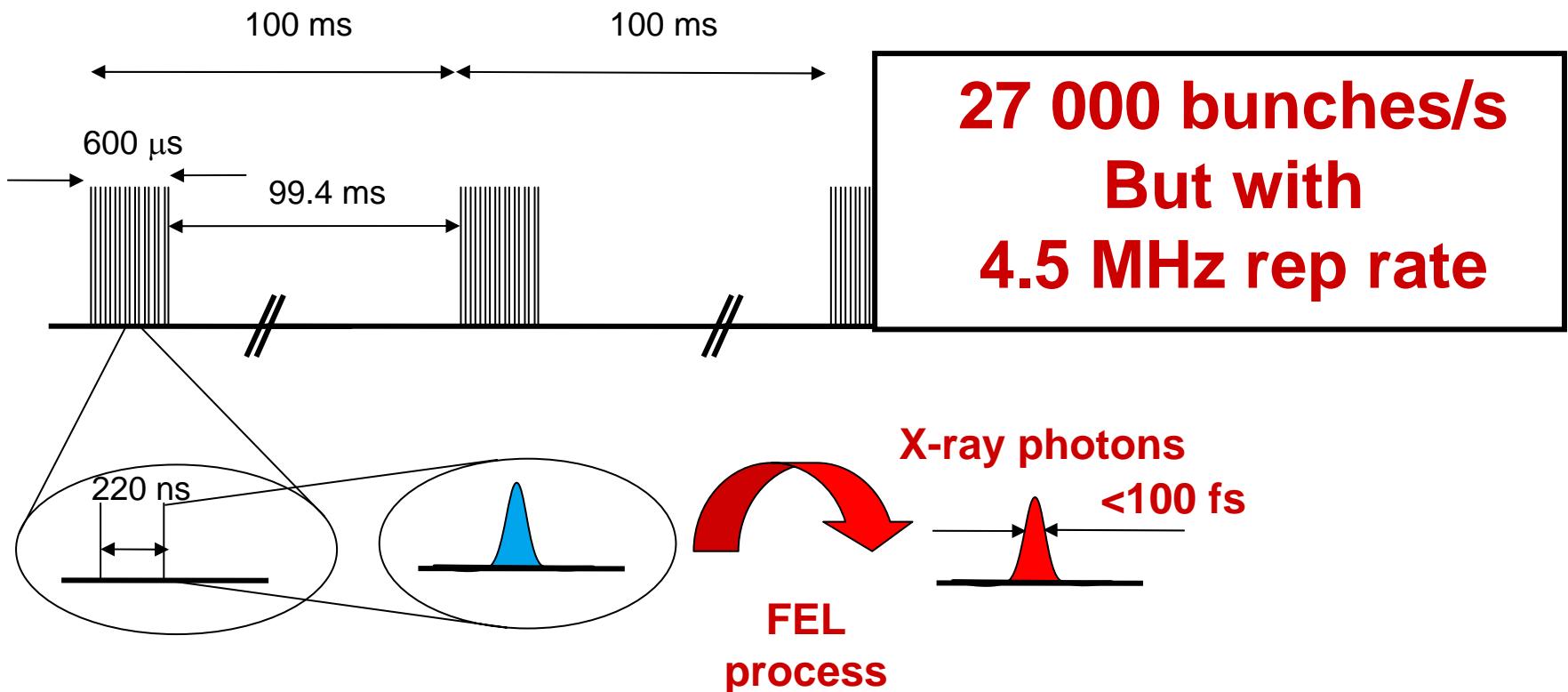
XFEL experiment complex at Schenefeld site



16.03.2011 - 16:25

E-XFEL Challenge: Time structure = difference with “others”

Electron bunch trains; up to 2700 bunches in 600 μ sec, repeated 10 times per second.
Producing 100 fsec X-ray pulses (up to 27 000 bunches per second).

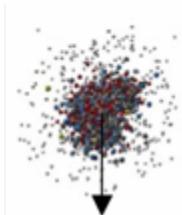


Single shot experiments

One pulse, one measurement

Particle injection

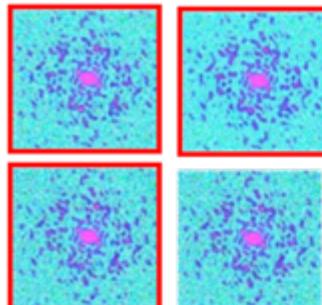
10 fs pulse



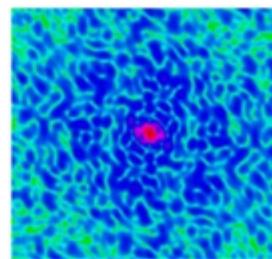
Noisy diffraction pattern

**Solve the well known
Phase Problem**

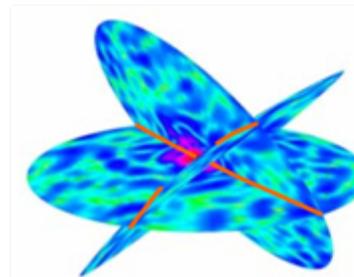
Combine 10^5 - 10^7 measurements



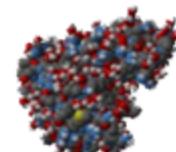
Classification



Averaging

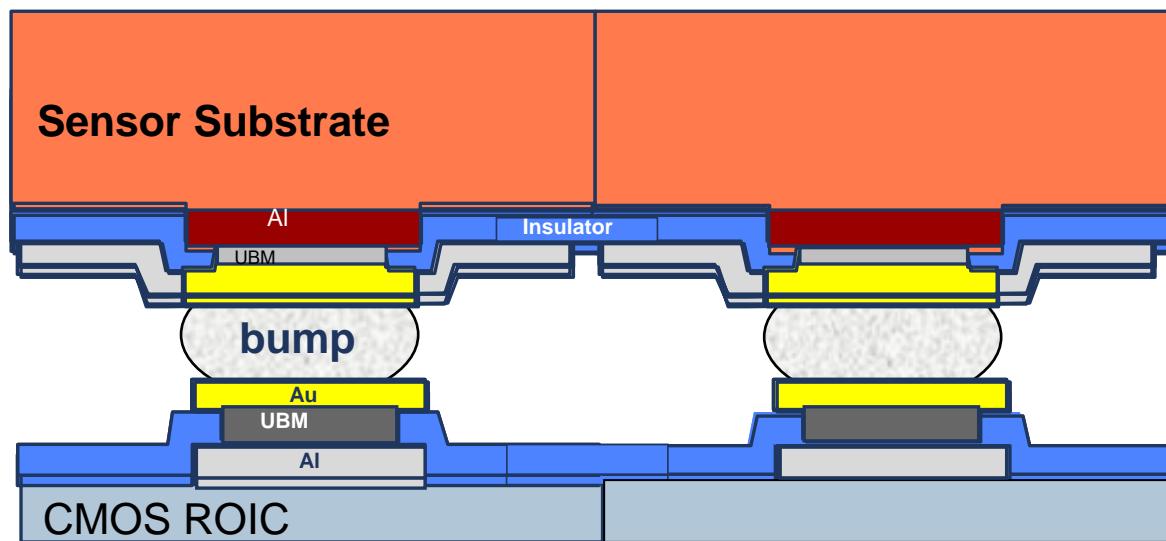
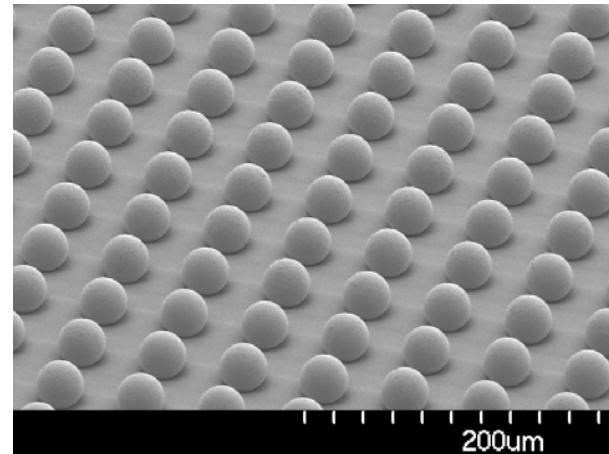
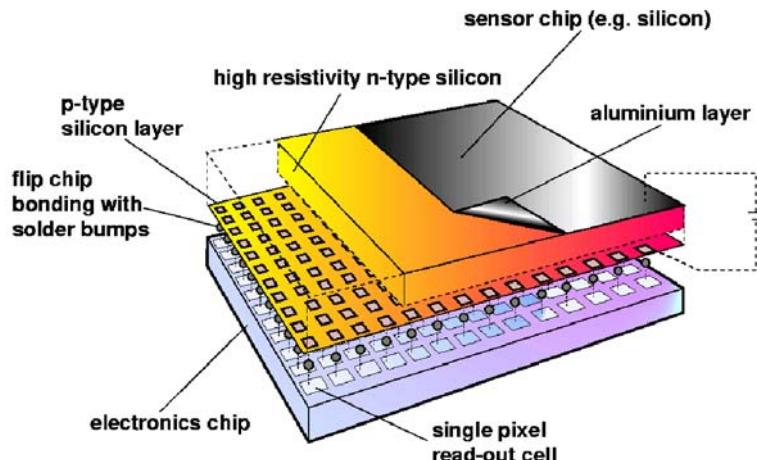


Orientation



Reconstruction
DESY

Hybrid Pixel Technology

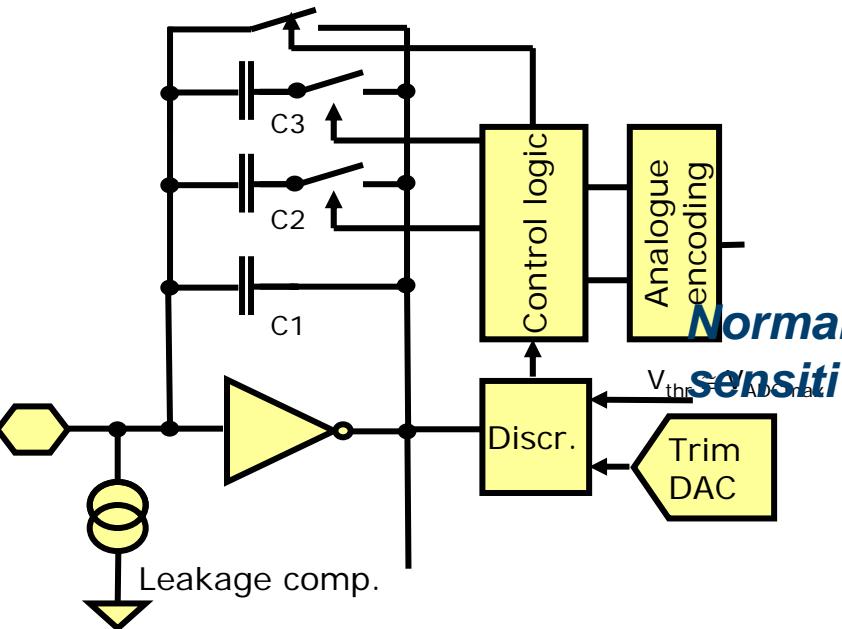


The Adaptive Gain Integrating Pixel Detector (AGIPD) project

The Adaptive Gain Integrating Pixel Detector

High dynamic range:

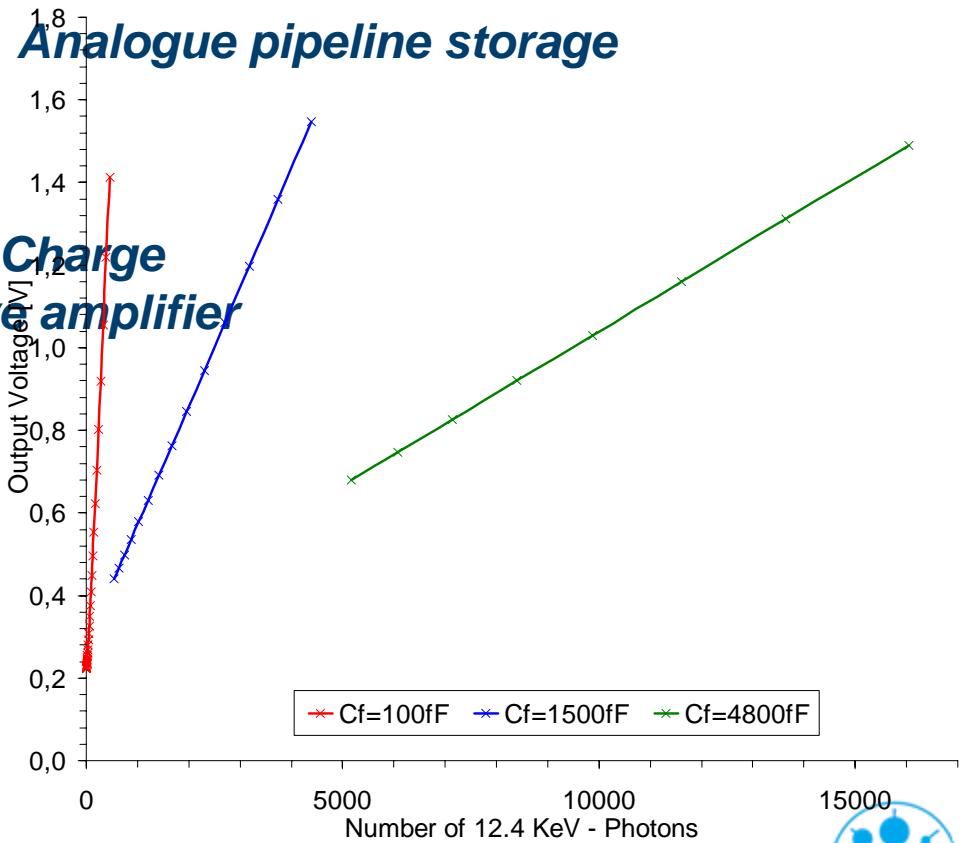
Dynamically gain switching system



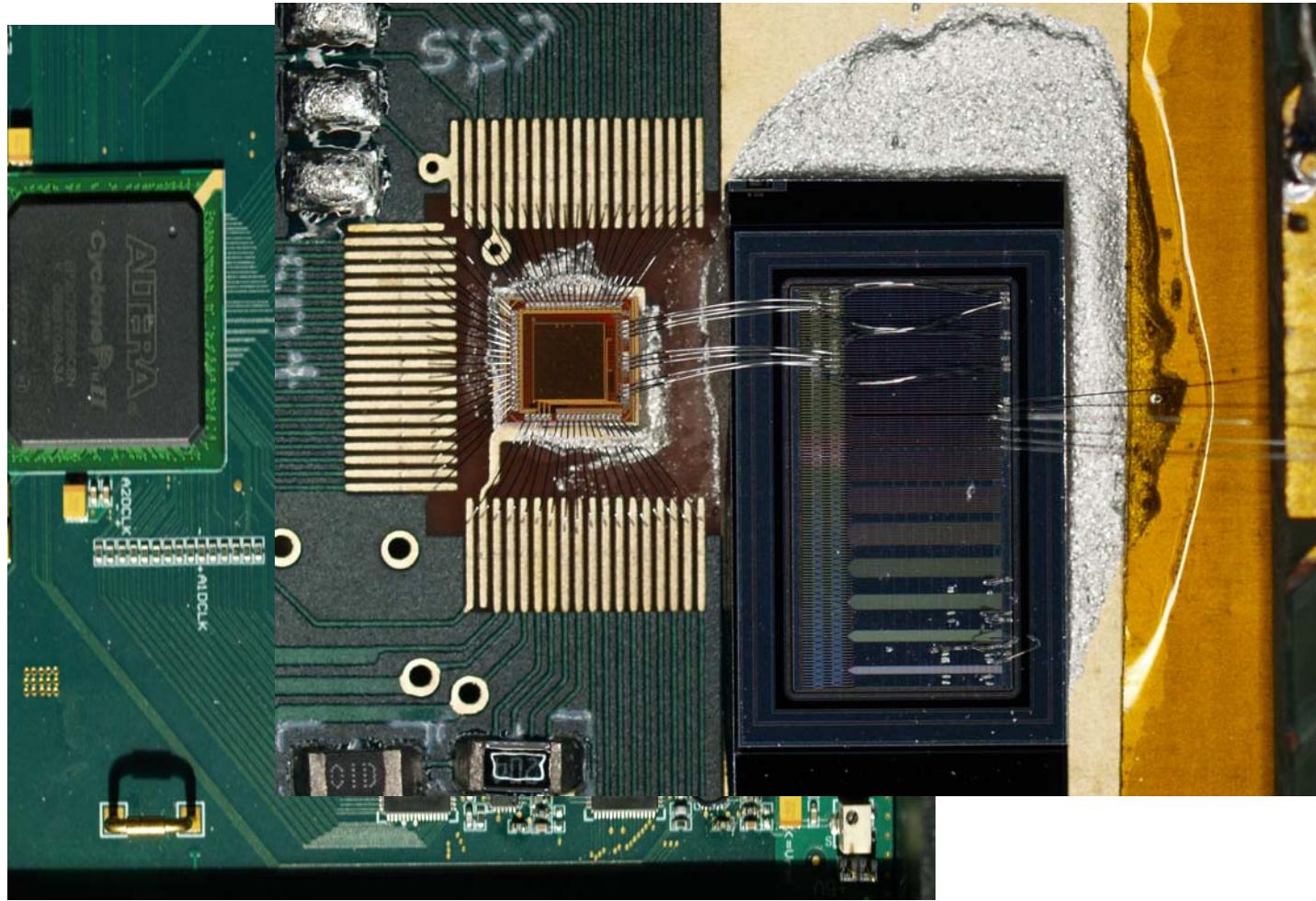
Extremely fast readout (200ns):

Analogue pipeline storage

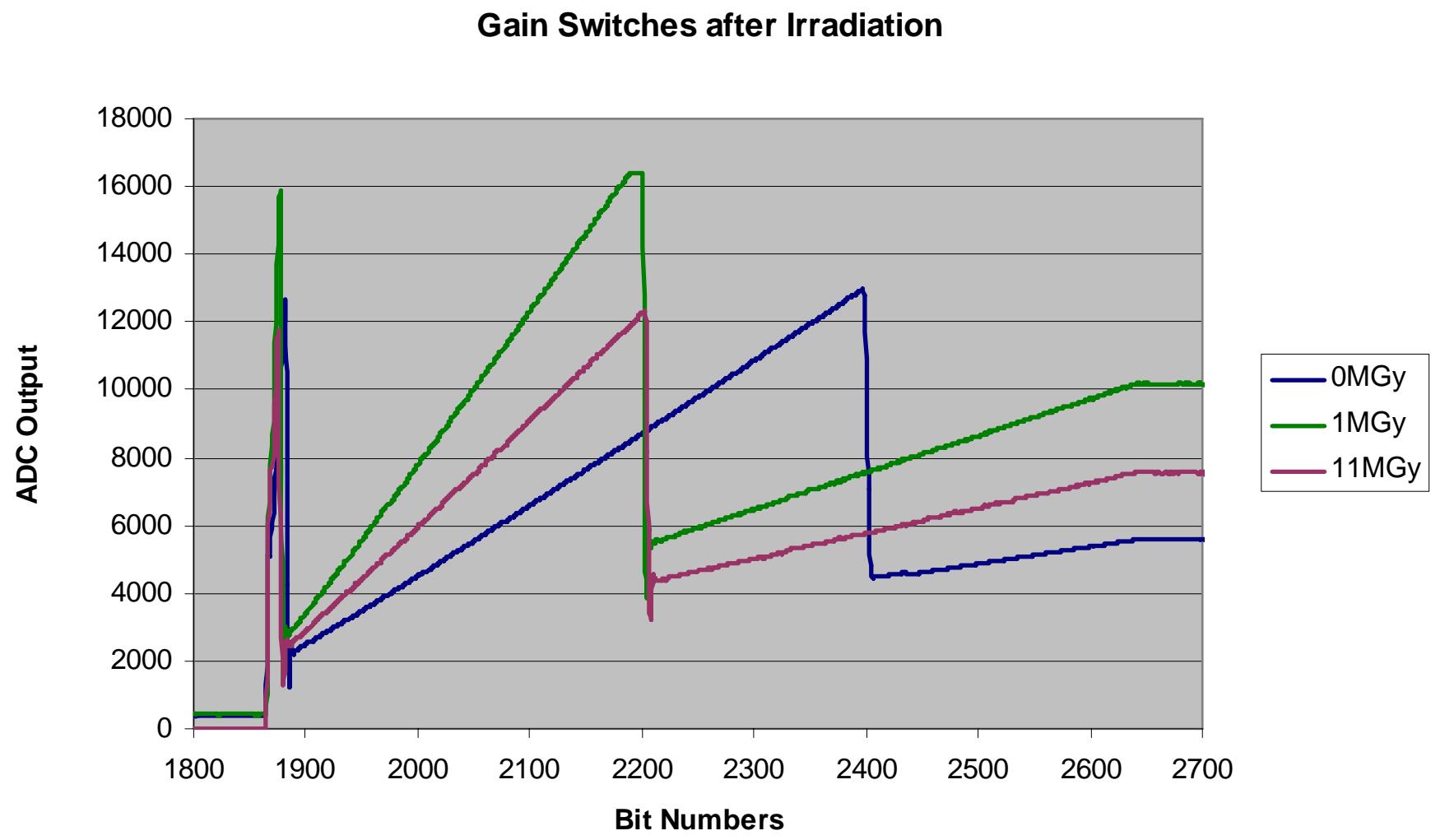
*Normal Charge
sensitive amplifier*



Overview of the chip test board



Dynamic Gain Switching works!

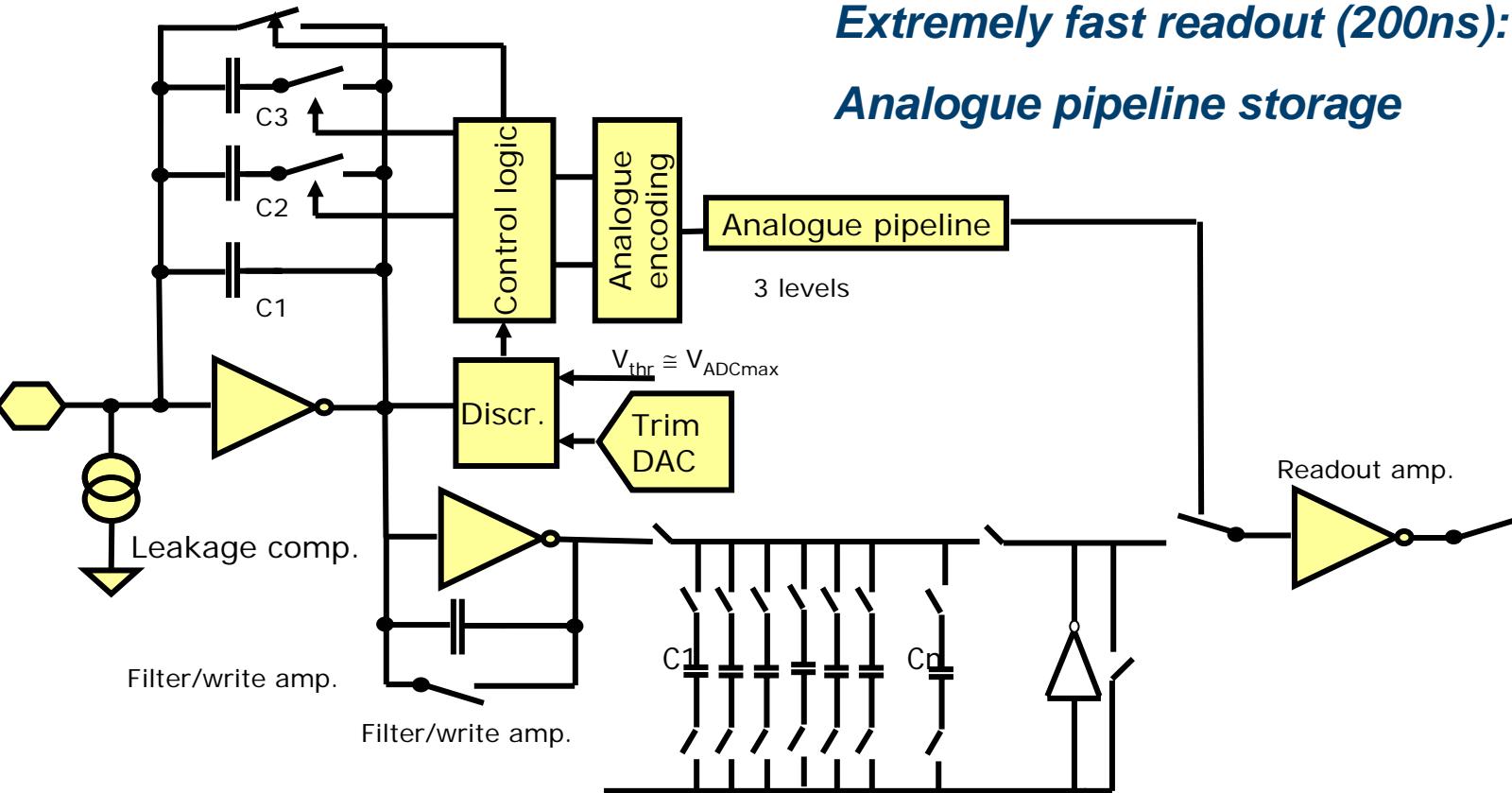


The Adaptive Gain Integrating Pixel Detector

High dynamic range:

Dynamically gain switching system

Extremely fast readout (200ns):
Analogue pipeline storage

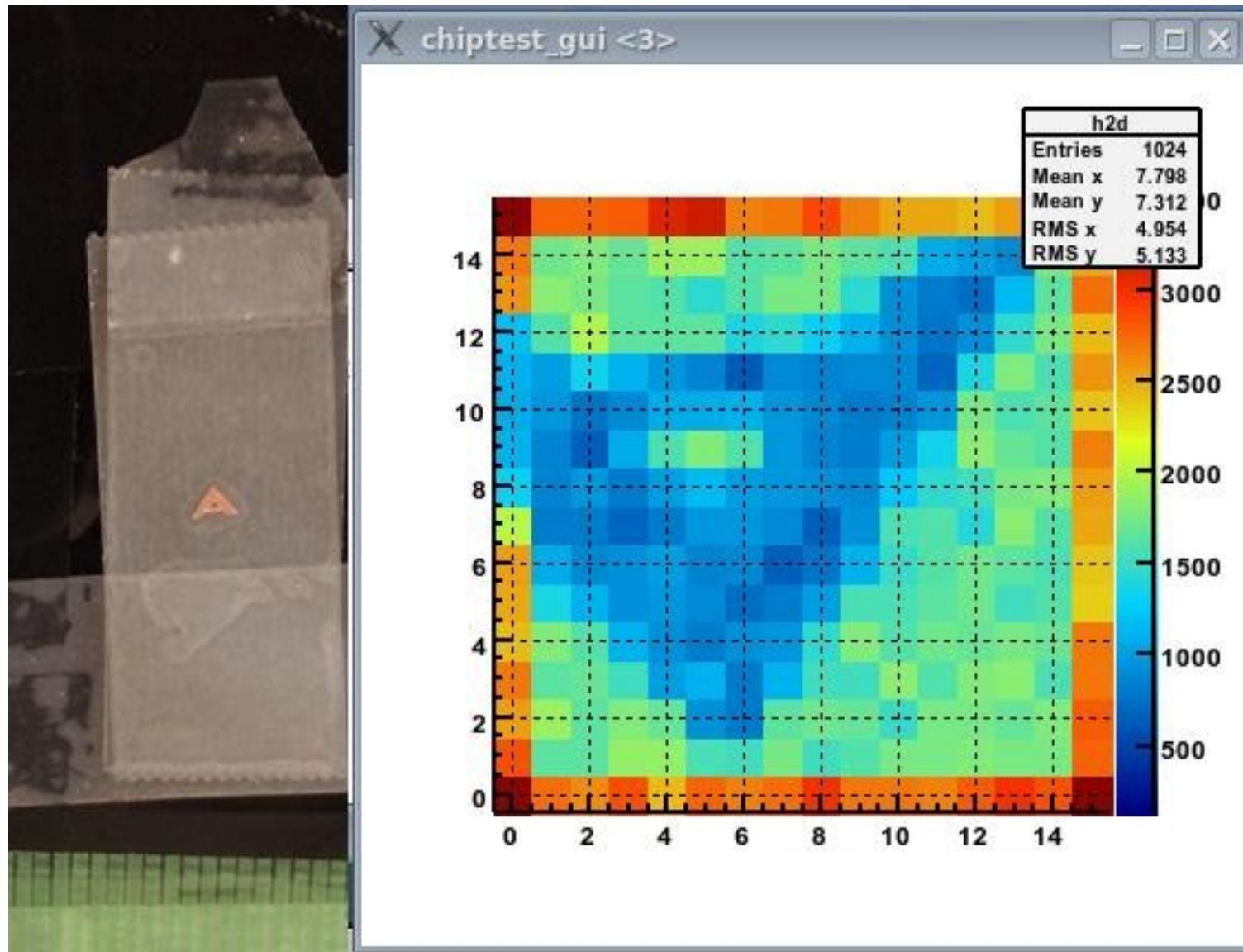


AGIPD02

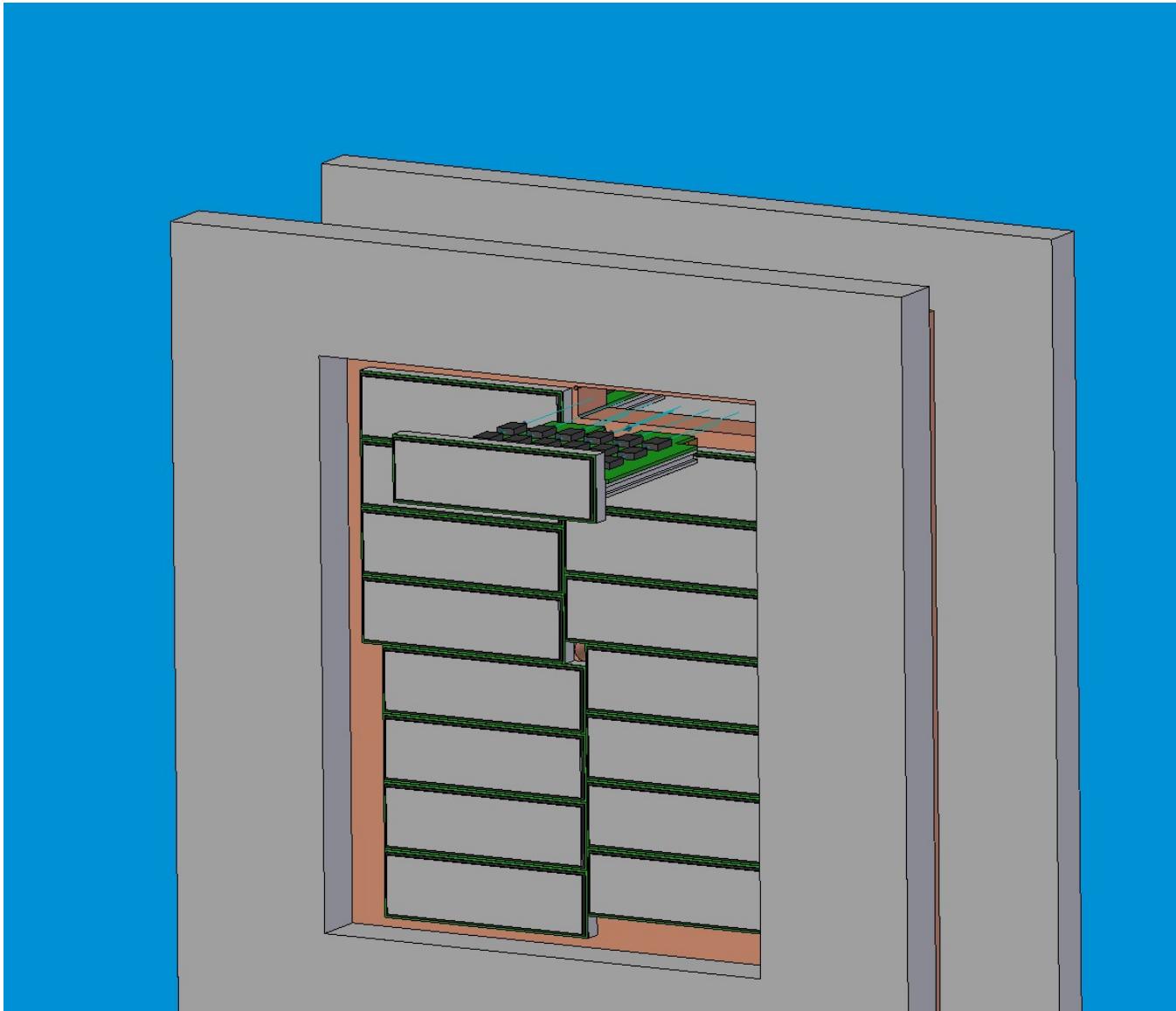
- 16 x 16 pixel prototype
- Adaptive gain
- Different flavors of storage
- 100 frames per pixel



First X-ray image taken with AGIPD02



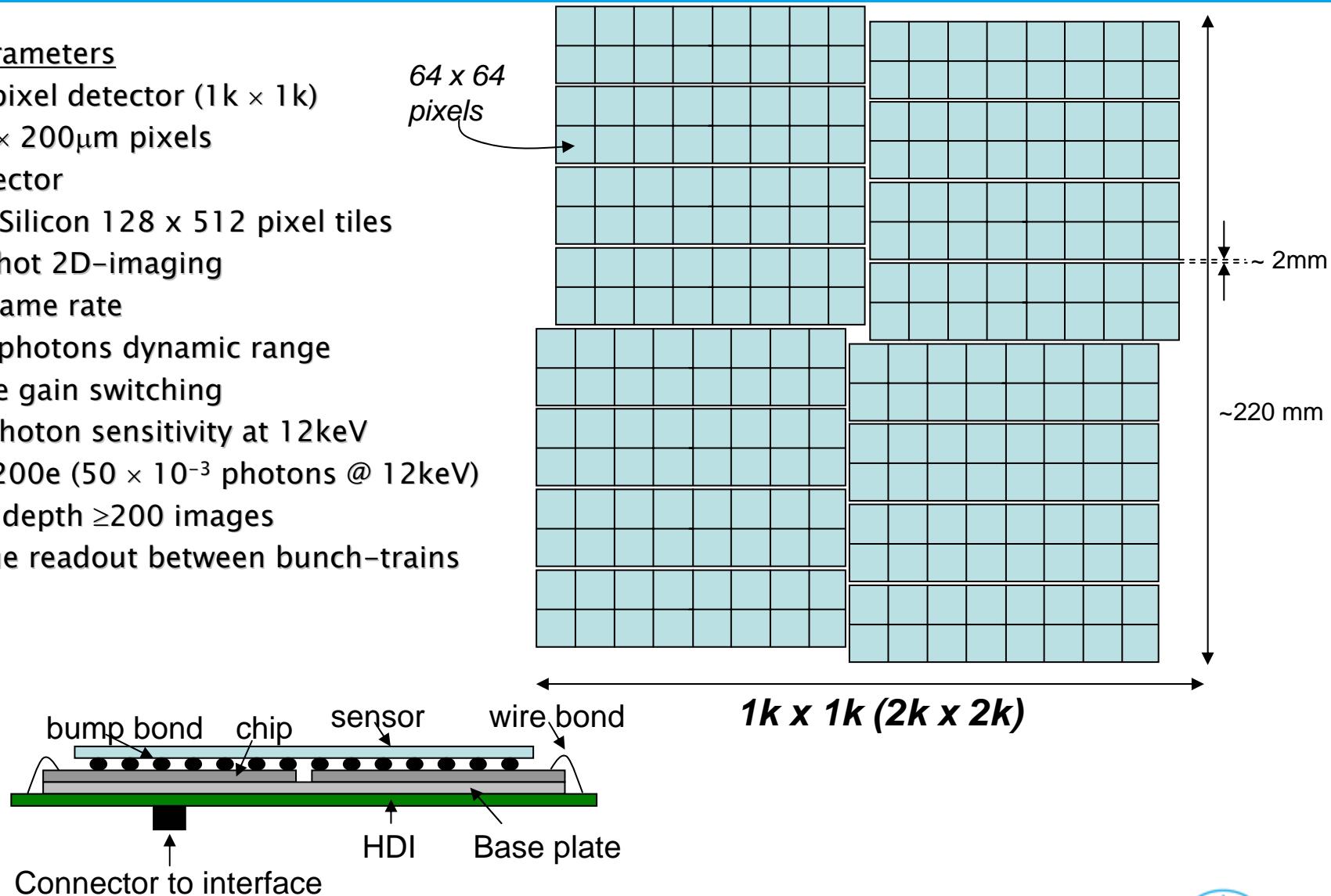
The 1k x 1k detector



The Adaptive Gain Integrating Pixel Detector

Basic parameters

- 1 Megapixel detector ($1k \times 1k$)
- $200\mu\text{m} \times 200\mu\text{m}$ pixels
- Flat detector
- Sensor: Silicon 128×512 pixel tiles
- Single shot 2D-imaging
- 5MHz frame rate
- 2×10^4 photons dynamic range
- Adaptive gain switching
- Single photon sensitivity at 12keV
- Noise $\leq 200e$ (50×10^{-3} photons @ 12keV)
- Storage depth ≥ 200 images
- Analogue readout between bunch-trains



The Adaptive Gain Integrating Pixel Detector

> The AGIPD consortium:

PSI/SLS -Villingen: chip design; interconnect and module assembly

Universität Bonn: chip design

Universität Hamburg: radiation damage tests, “charge explosion” studies; and sensor design

DESY: chip design, interface and control electronics, mechanics, cooling; overall coordination

Some Facts

5 years development

~ 20 people



Some Milestones

First 16x16 pixels prototype

End 2010

Definition of final design

Summer 2011

Production, assembly and test

>2013



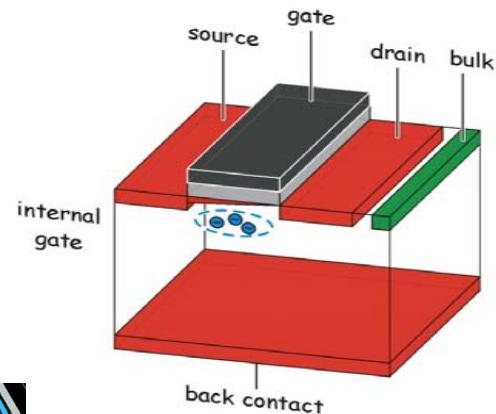
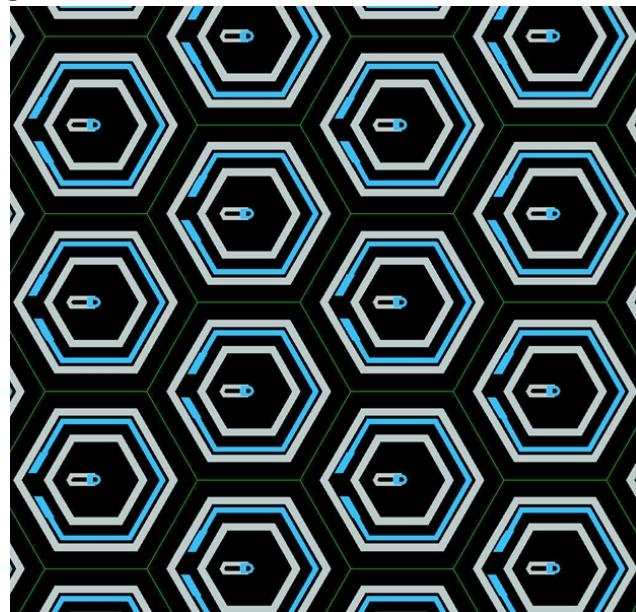
The DEPFET Sensor with Signal Compression (DSSC)

DSSC - DEPMOS Sensor with Signal Compression

- > DEPFET per pixel
- > Very low noise (good for soft X-rays)
- > non linear gain (good for dynamic range)
- > per pixel ADC
- > digital storage pipeline

> Hexagonal pixels 200 μ m pitch

- combines DEPFET
- with small area drift detector (scaleable)

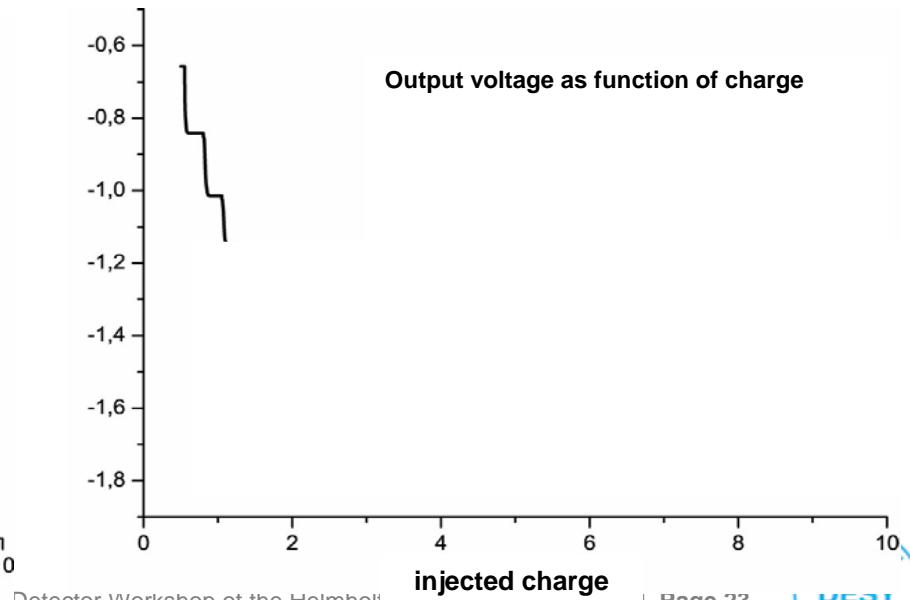
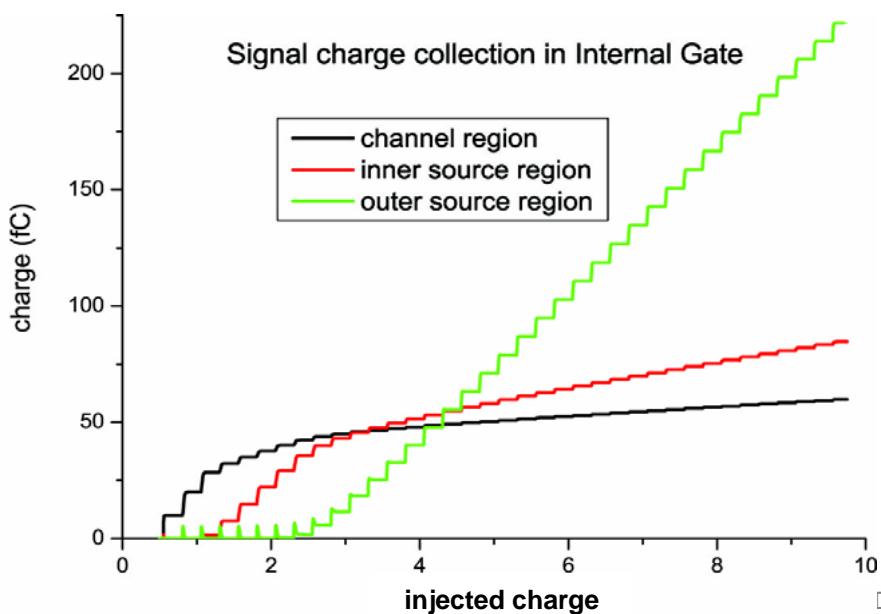
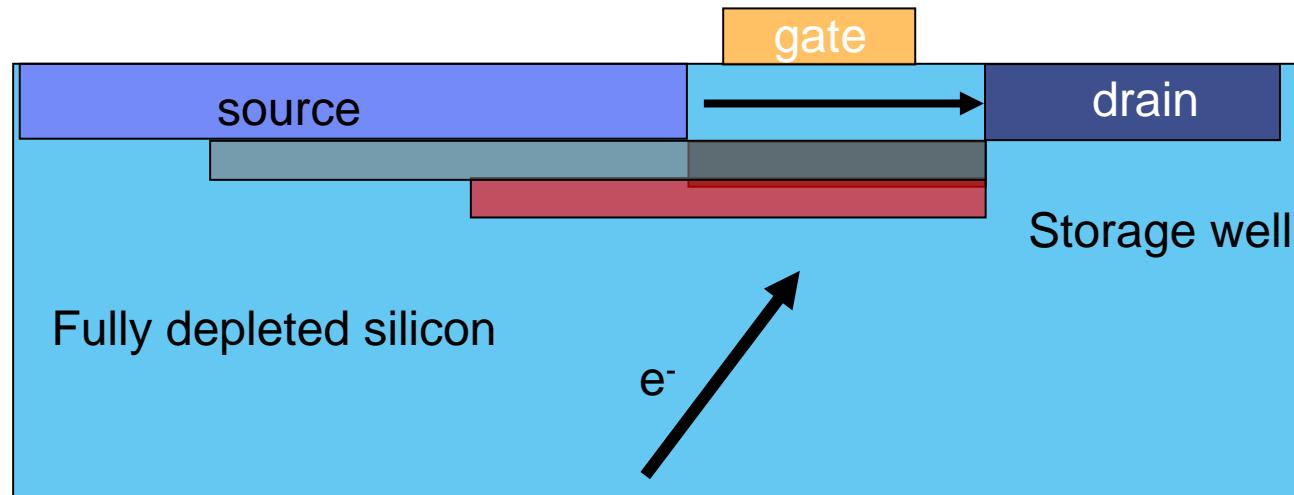
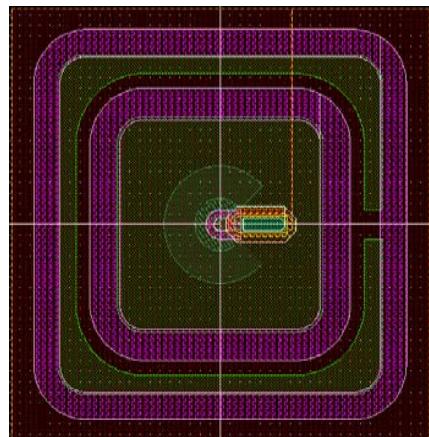


- > MPI-HLL, Munich
- > Universität Heidelberg
- > Universität Siegen
- > Politecnico di Milano
- > Università di Bergamo
- > DESY, Hamburg

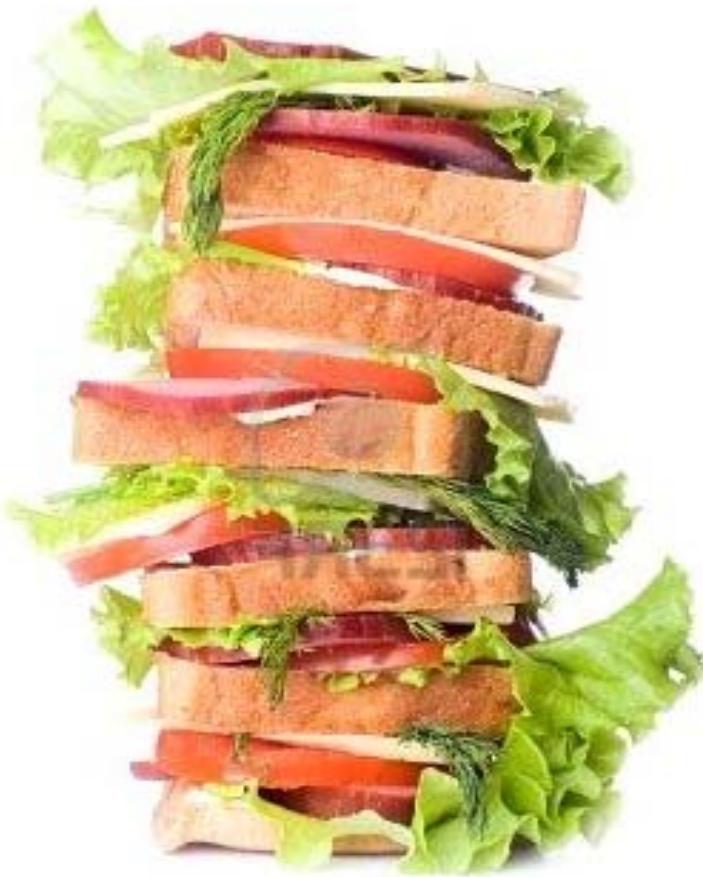
DEPMOS Sensor with Signal Compression

DEPFET: Electrons are collected in a storage well

⇒ Influence current from source to drain



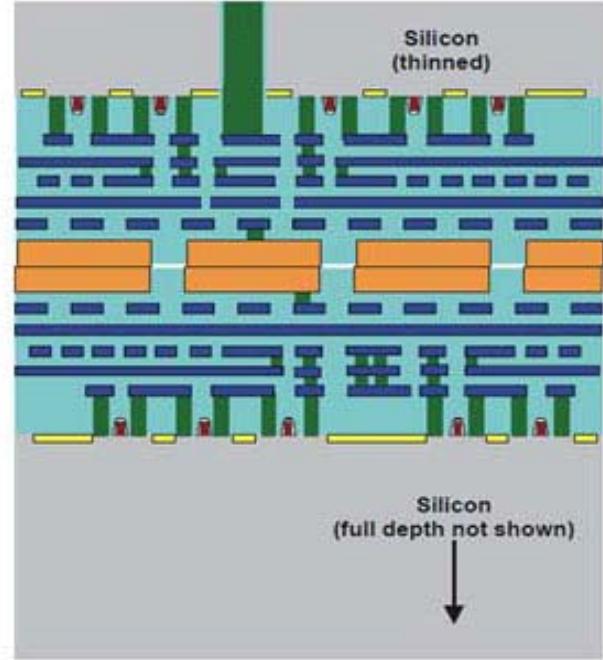
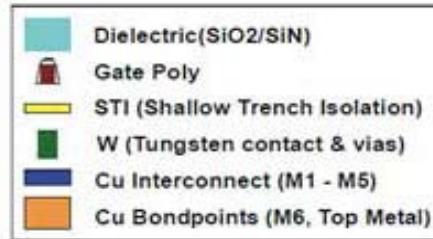
why to go vertical



- > Increased effective area
 - cheating on the area constraint
- > better I/O connections
 - shorter, faster, and more of them
- > integration of different technologies
 - select the most suitable tech to do each thing

going vertical: a simple AGIPD evolution hypothesis

- > Chartered-Tezzaron technology
- > CMOS Low Power, 130 nm , 1.5 V
- > available for MPW through MOSIS



other hypothesis

- > Ziptronix (3D bonding only)
- > Fraunhofer (TSV only)
- > IMEC (developing)
- > AMS (developed but not commercially available yet)
- > IBM (TSV not insulated yet)
- > 3D Package (Amkor, Tessera)

going vertical: a simple AGIPD evolution hypothesis

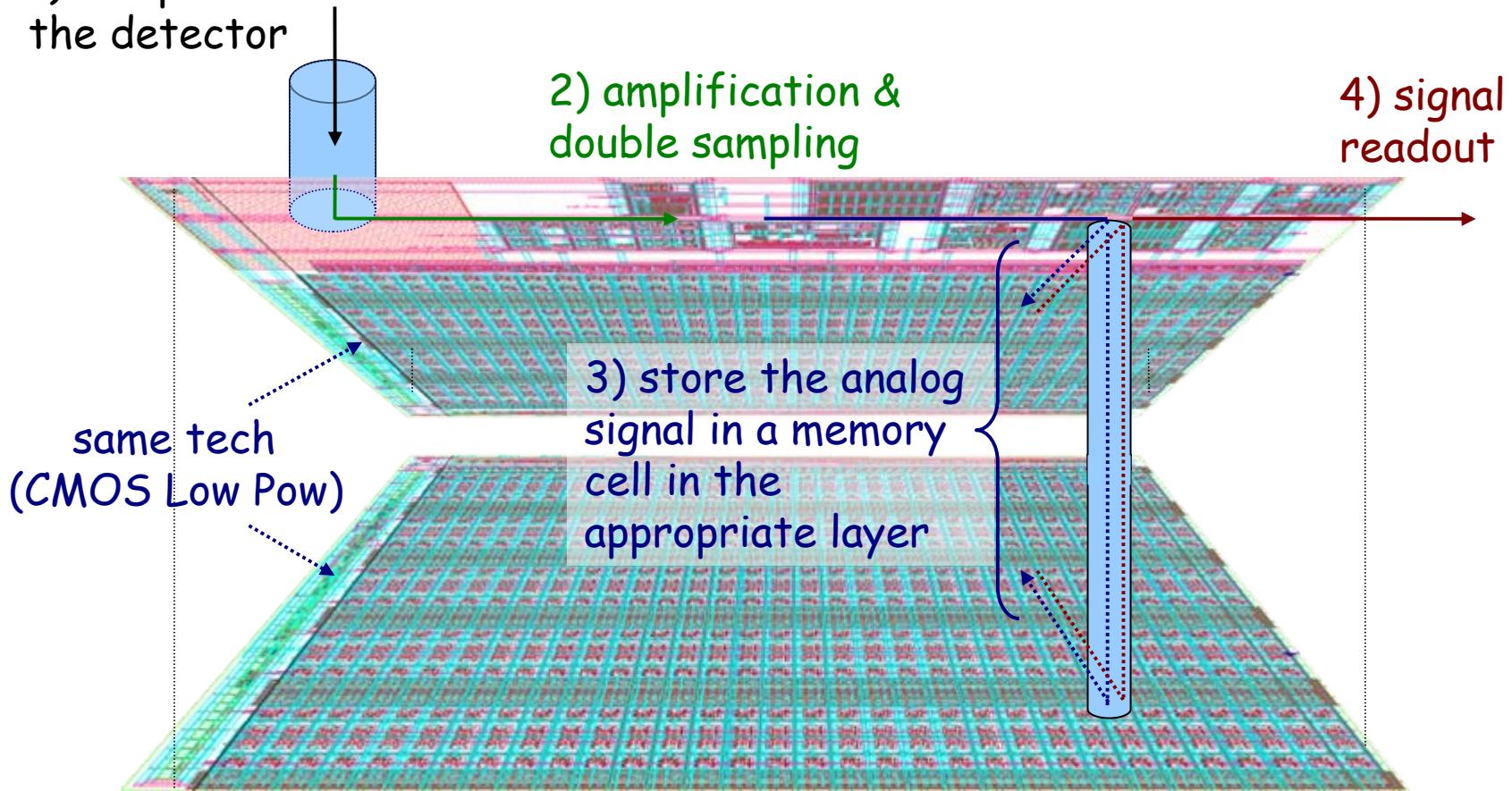
> near future: "logic - on - logic"

- MPW to be submitted in summer

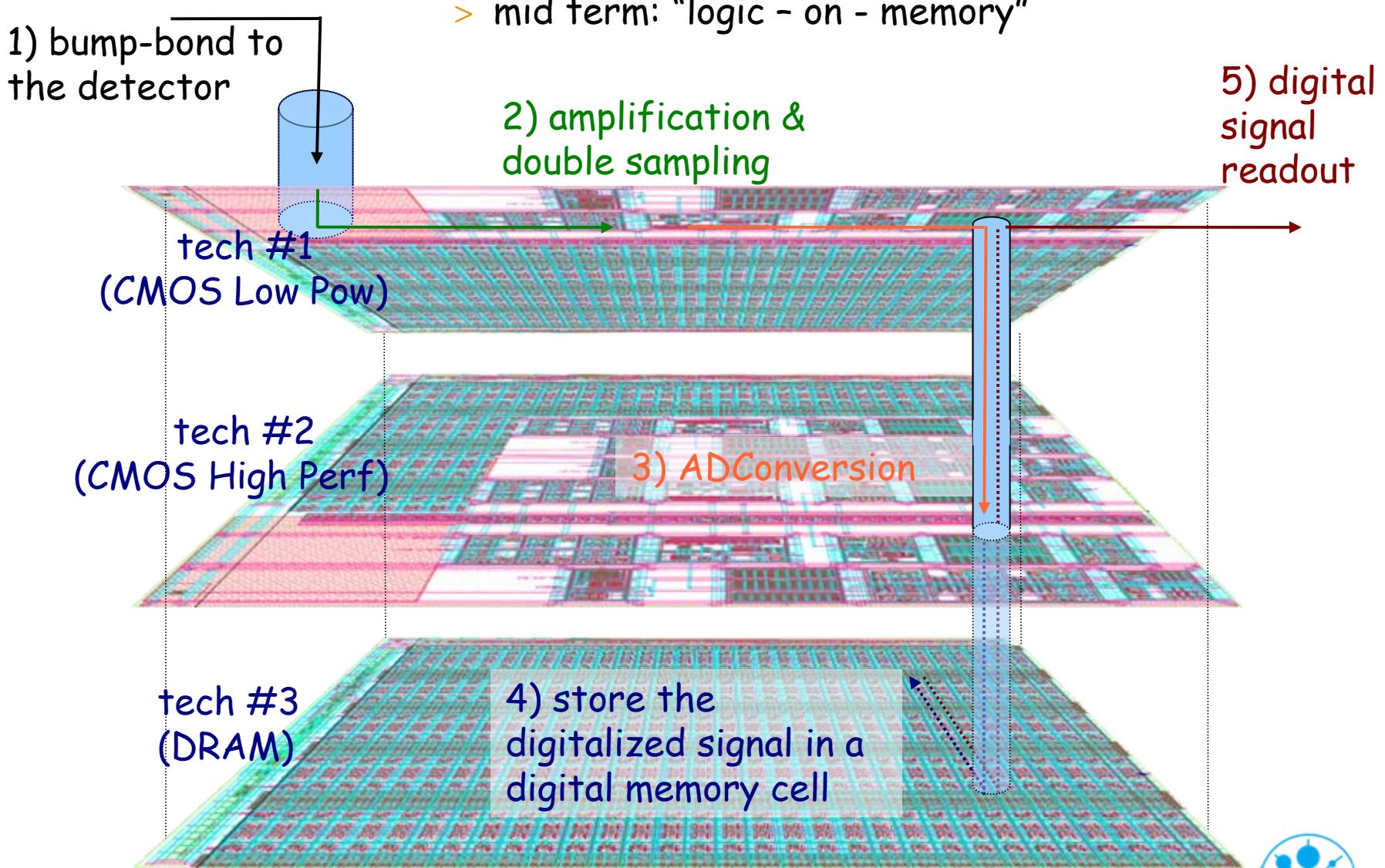
1) bump-bond to
the detector

2) amplification &
double sampling

4) signal
readout



going vertical: a simple AGIPD evolution hypothesis



Summary

- > FELs need conceptually new detectors: fast, low noise, large dynamic range
- > Dedicated detector developments for Photon Science (Europe, Japan and USA)
- > Detectors will be decisive for the success of the European XFEL (bunch train structure).
- > Photon Science possibly driving force for new detector developments, but synergy with HEP essential.